

Notice of References Cited	Application/Control No. 10/525,929	Applicant(s)/Patent Under Reexamination SEKI ET AL.	
	Examiner Rip A. Lee	Art Unit 1713	Page 1 of 1


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*	B	US-6,150,544 A	11-2000	Seki et al.	556/27
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NON-PATENT DOCUMENTS

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*	U	Sinn et al. Angew. Chem., 1980, 5, 396-402
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September 08, 2006

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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